

Notice of References Cited	Application/Control No. 09/579,576	Applicant(s)/Patent Under Reexamination KWEON ET AL.	
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*	B	US-5869208	02-1999	Miyasaka	429	224
*	C	US-5922491	07-1999	Ikawa et al.	429	218
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	E	US-6153338 <i>11/6000</i>	08-1998 <i>2003</i>	Gan et al.	429	326
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NON-PATENT DOCUMENTS

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